## Notice of References Cited

Application/Control No. 10/658,536	Reexamination	Applicant(s)/Patent Under Reexamination UENO ET AL.	
Examiner	Art Unit		
Tu M. Nguyen	3748	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,946,906	09-1999	Akazaki et al.	60/278
	В	US-6,321,533	11-2001	Watanabe et al.	60/324
	O	US-5,746,049	05-1998	Cullen et al.	60/274
	۵	US-5,524,433	06-1996	Adamczyk et al.	60/276
	E	US-5,635,633	06-1997	Kadota, Yoichi	73/118.1
	F	US-5,765,369	06-1998	Tanaka et al.	60/277
	G	US-5,956,947	09-1999	Tanaka et al.	60/297
	Н	US-			
	1	US-			
	J	US-			AA
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	O					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	V			
	W			
	х			

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